

# IRFP31N50LPbF

## Applications

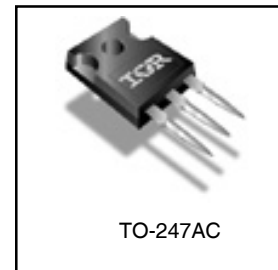
- Zero Voltage Switching SMPS
- Telecom and Server Power Supplies
- Uninterruptible Power Supplies
- Motor Control applications
- Lead-Free

HEXFET® Power MOSFET

| $V_{DSS}$ | $R_{DS(on)}$ typ. | $T_{rr}$ typ. | $I_D$ |
|-----------|-------------------|---------------|-------|
| 500V      | 0.15 $\Omega$     | 170ns         | 31A   |

## Features and Benefits

- SuperFast body diode eliminates the need for external diodes in ZVS applications.
- Lower Gate charge results in simpler drive requirements.
- Enhanced dv/dt capabilities offer improved ruggedness.
- Higher Gate voltage threshold offers improved noise immunity.



## Absolute Maximum Ratings

|                                   | Parameter                                | Max.                   | Units               |
|-----------------------------------|------------------------------------------|------------------------|---------------------|
| $I_D$ @ $T_C = 25^\circ\text{C}$  | Continuous Drain Current, $V_{GS}$ @ 10V | 31                     | A                   |
| $I_D$ @ $T_C = 100^\circ\text{C}$ | Continuous Drain Current, $V_{GS}$ @ 10V | 20                     |                     |
| $I_{DM}$                          | Pulsed Drain Current ①                   | 124                    |                     |
| $P_D$ @ $T_C = 25^\circ\text{C}$  | Power Dissipation                        | 460                    | W                   |
|                                   | Linear Derating Factor                   | 3.7                    | W/ $^\circ\text{C}$ |
| $V_{GS}$                          | Gate-to-Source Voltage                   | $\pm 30$               | V                   |
| dv/dt                             | Peak Diode Recovery dv/dt ②              | 19                     | V/ns                |
| $T_J$                             | Operating Junction and                   | -55 to + 150           | $^\circ\text{C}$    |
| $T_{STG}$                         | Storage Temperature Range                |                        |                     |
|                                   | Soldering Temperature, for 10 seconds    | 300 (1.6mm from case ) |                     |
|                                   | Mounting torque, 6-32 or M3 screw        | 10lb·in (1.1N·m)       |                     |

## Diode Characteristics

| Symbol    | Parameter                                 | Min.                                                                 | Typ. | Max. | Units | Conditions                                                             |
|-----------|-------------------------------------------|----------------------------------------------------------------------|------|------|-------|------------------------------------------------------------------------|
| $I_S$     | Continuous Source Current<br>(Body Diode) | —                                                                    | —    | 31   | A     | MOSFET symbol showing the integral reverse p-n junction diode.         |
| $I_{SM}$  | Pulsed Source Current<br>(Body Diode) ①   | —                                                                    | —    | 124  |       |                                                                        |
| $V_{SD}$  | Diode Forward Voltage                     | —                                                                    | —    | 1.5  | V     | $T_J = 25^\circ\text{C}$ , $I_S = 31\text{A}$ , $V_{GS} = 0\text{V}$ ④ |
| $t_{rr}$  | Reverse Recovery Time                     | —                                                                    | 170  | 250  | ns    | $T_J = 25^\circ\text{C}$ , $I_F = 31\text{A}$                          |
|           |                                           | —                                                                    | 220  | 330  |       | $T_J = 125^\circ\text{C}$ , $di/dt = 100\text{A}/\mu\text{s}$ ④        |
| $Q_{rr}$  | Reverse Recovery Charge                   | —                                                                    | 570  | 860  | nC    | $T_J = 25^\circ\text{C}$ , $I_S = 31\text{A}$ , $V_{GS} = 0\text{V}$ ④ |
|           |                                           | —                                                                    | 1.2  | 1.8  |       | $T_J = 125^\circ\text{C}$ , $di/dt = 100\text{A}/\mu\text{s}$ ④        |
| $I_{RRM}$ | Reverse Recovery Current                  | —                                                                    | 7.9  | 12   | A     | $T_J = 25^\circ\text{C}$                                               |
| $t_{on}$  | Forward Turn-On Time                      | Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD) |      |      |       |                                                                        |

2/26/04

# IRFP31N50LPbF

International  
IR Rectifier

Static @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)

| Symbol                          | Parameter                            | Min. | Typ. | Max. | Units               | Conditions                                            |
|---------------------------------|--------------------------------------|------|------|------|---------------------|-------------------------------------------------------|
| $V_{(BR)DSS}$                   | Drain-to-Source Breakdown Voltage    | 500  | —    | —    | V                   | $V_{GS} = 0V, I_D = 250\mu A$                         |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient  | —    | 0.28 | —    | V/ $^\circ\text{C}$ | Reference to $25^\circ\text{C}$ , $I_D = 1mA$         |
| $R_{DS(on)}$                    | Static Drain-to-Source On-Resistance | —    | 0.15 | 0.18 | $\Omega$            | $V_{GS} = 10V, I_D = 19A$ ④                           |
| $V_{GS(th)}$                    | Gate Threshold Voltage               | 3.0  | —    | 5.0  | V                   | $V_{DS} = V_{GS}, I_D = 250\mu A$                     |
| $I_{DSS}$                       | Drain-to-Source Leakage Current      | —    | —    | 50   | $\mu A$             | $V_{DS} = 500V, V_{GS} = 0V$                          |
|                                 |                                      | —    | —    | 2.0  | mA                  | $V_{DS} = 400V, V_{GS} = 0V, T_J = 125^\circ\text{C}$ |
| $I_{GSS}$                       | Gate-to-Source Forward Leakage       | —    | —    | 100  | nA                  | $V_{GS} = 30V$                                        |
|                                 | Gate-to-Source Reverse Leakage       | —    | —    | -100 | nA                  | $V_{GS} = -30V$                                       |
| $R_G$                           | Internal Gate Resistance             | —    | 1.1  | —    | $\Omega$            | $f = 1MHz$ , open drain                               |

Dynamic @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)

| Symbol                      | Parameter                                        | Min. | Typ. | Max. | Units | Conditions                                    |
|-----------------------------|--------------------------------------------------|------|------|------|-------|-----------------------------------------------|
| $g_{fs}$                    | Forward Transconductance                         | 15   | —    | —    | S     | $V_{DS} = 50V, I_D = 19A$                     |
| $Q_g$                       | Total Gate Charge                                | —    | —    | 210  | nC    | $I_D = 31A$                                   |
| $Q_{gs}$                    | Gate-to-Source Charge                            | —    | —    | 58   | nC    | $V_{DS} = 400V$                               |
| $Q_{gd}$                    | Gate-to-Drain ("Miller") Charge                  | —    | —    | 100  | nC    | $V_{GS} = 10V$ , See Fig. 7 & 15 ④            |
| $t_{d(on)}$                 | Turn-On Delay Time                               | —    | 28   | —    | ns    | $V_{DD} = 250V$                               |
| $t_r$                       | Rise Time                                        | —    | 115  | —    | ns    | $I_D = 31A$                                   |
| $t_{d(off)}$                | Turn-Off Delay Time                              | —    | 54   | —    | ns    | $R_G = 4.3\Omega$                             |
| $t_f$                       | Fall Time                                        | —    | 53   | —    | ns    | $V_{GS} = 10V$ , See Fig. 14a & 14b ④         |
| $C_{iss}$                   | Input Capacitance                                | —    | 5000 | —    | pF    | $V_{GS} = 0V$                                 |
| $C_{oss}$                   | Output Capacitance                               | —    | 553  | —    | pF    | $V_{DS} = 25V$                                |
| $C_{rss}$                   | Reverse Transfer Capacitance                     | —    | 59   | —    | pF    | $f = 1.0MHz$ , See Fig. 5                     |
| $C_{oss}$                   | Output Capacitance                               | —    | 6630 | —    | pF    | $V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0MHz$      |
| $C_{oss}$                   | Output Capacitance                               | —    | 155  | —    | pF    | $V_{GS} = 0V, V_{DS} = 400V, f = 1.0MHz$      |
| $C_{oss \text{ eff.}}$      | Effective Output Capacitance                     | —    | 276  | —    | pF    | $V_{GS} = 0V, V_{DS} = 0V \text{ to } 400V$ ⑤ |
| $C_{oss \text{ eff. (ER)}}$ | Effective Output Capacitance<br>(Energy Related) | —    | 200  | —    | pF    |                                               |

## Avalanche Characteristics

| Symbol   | Parameter                       | Typ. | Max. | Units |
|----------|---------------------------------|------|------|-------|
| $E_{AS}$ | Single Pulse Avalanche Energy ② | —    | 460  | mJ    |
| $I_{AR}$ | Avalanche Current ①             | —    | 31   | A     |
| $E_{AR}$ | Repetitive Avalanche Energy ①   | —    | 46   | mJ    |

## Thermal Resistance

| Symbol          | Parameter                           | Typ. | Max. | Units              |
|-----------------|-------------------------------------|------|------|--------------------|
| $R_{\theta JC}$ | Junction-to-Case                    | —    | 0.26 | $^\circ\text{C/W}$ |
| $R_{\theta CS}$ | Case-to-Sink, Flat, Greased Surface | 0.24 | —    |                    |
| $R_{\theta JA}$ | Junction-to-Ambient                 | —    | 40   |                    |

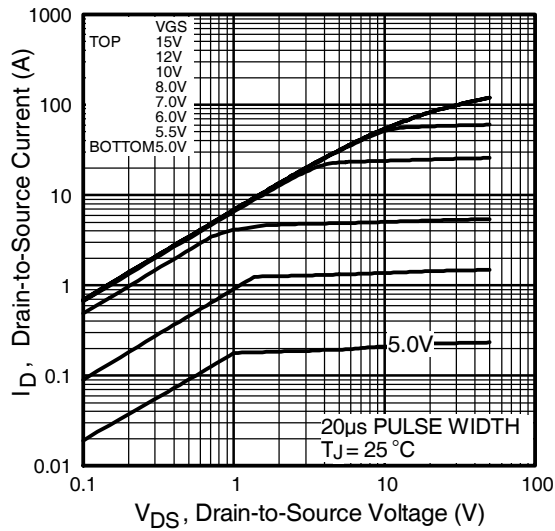
### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See Fig. 11)
- ② Starting  $T_J = 25^\circ\text{C}$ ,  $L = 1mH$ ,  $R_G = 25\Omega$ ,  $I_{AS} = 31A$  (See Figure 12).
- ③  $I_{SD} = 31A$ ,  $di/dt \leq 422A/\mu s$ ,  $V_{DD} \leq V_{(BR)DSS}$ ,  $T_J \leq 150^\circ\text{C}$ .

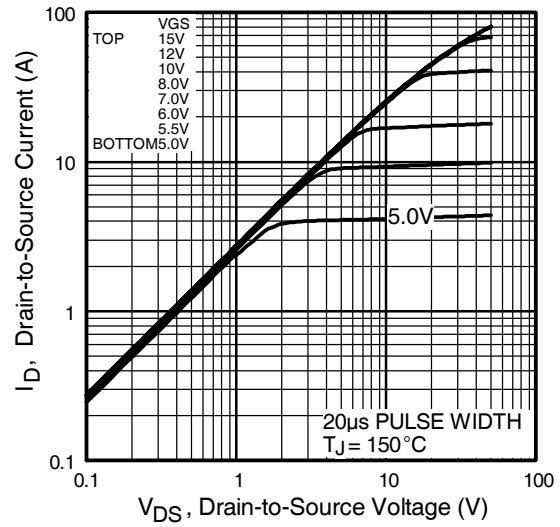
- ④ Pulse width  $\leq 300\mu s$ ; duty cycle  $\leq 2\%$ .

- ⑤  $C_{oss \text{ eff.}}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .  
 $C_{oss \text{ eff. (ER)}}$  is a fixed capacitance that stores the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .

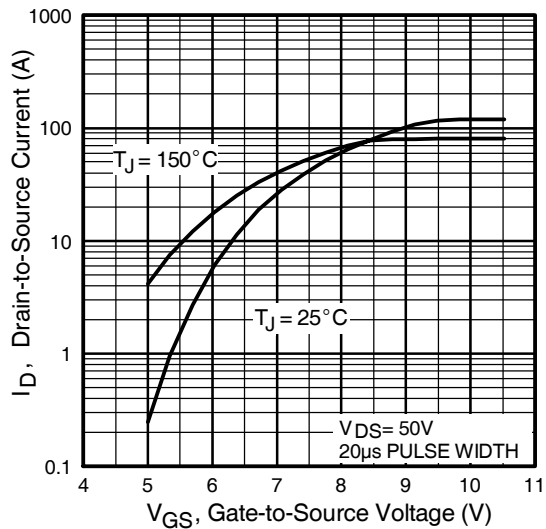
# IRFP31N50LPbF



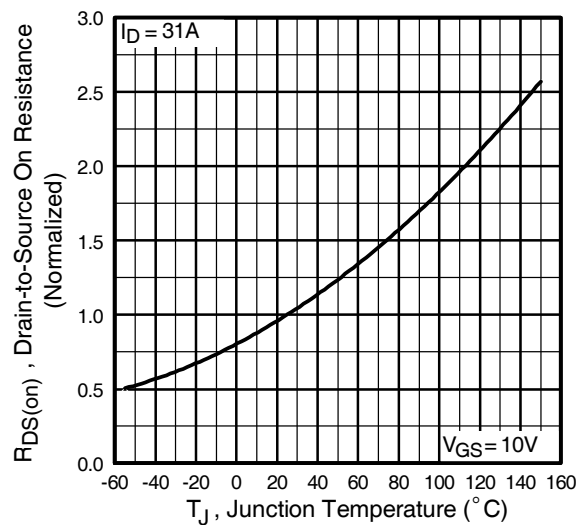
**Fig 1.** Typical Output Characteristics



**Fig 2.** Typical Output Characteristics



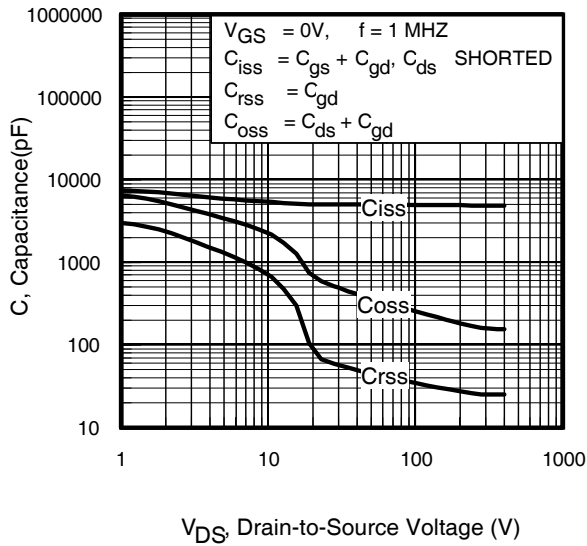
**Fig 3.** Typical Transfer Characteristics



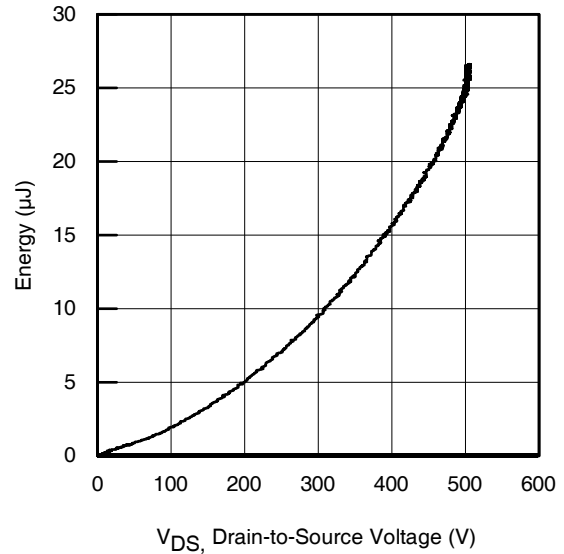
**Fig 4.** Normalized On-Resistance Vs. Temperature

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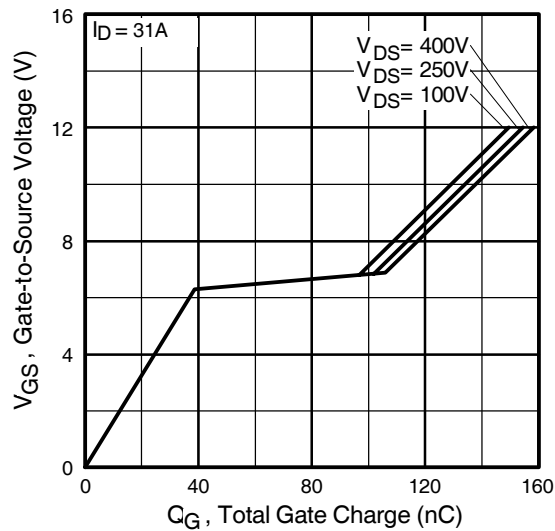
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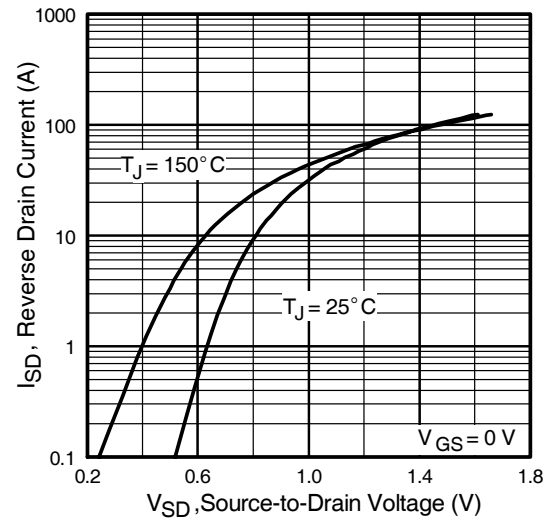
**Fig 5.** Typical Capacitance vs. Drain-to-Source Voltage



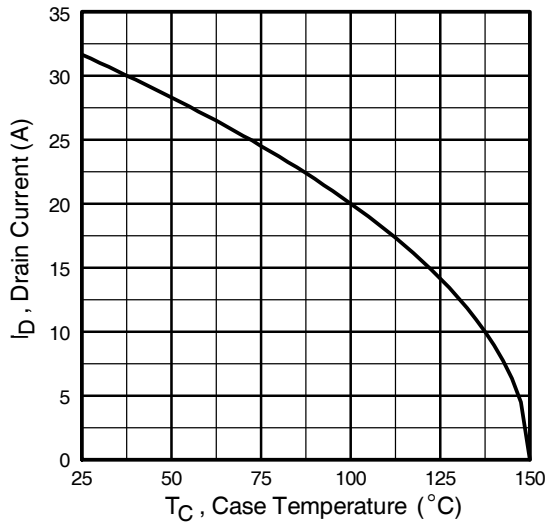
**Fig 6.** Typ. Output Capacitance Stored Energy vs.  $V_{DS}$



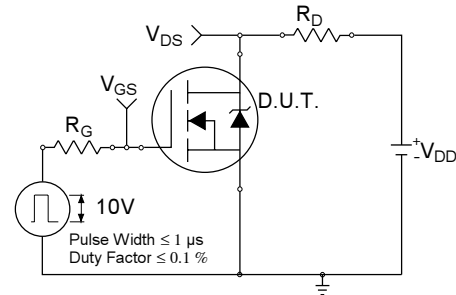
**Fig 7.** Typical Gate Charge vs. Gate-to-Source Voltage



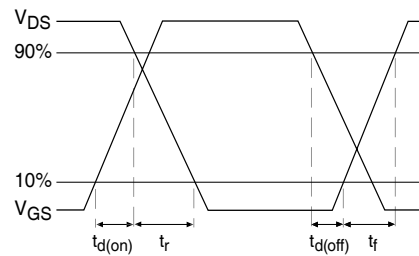
**Fig 8.** Typical Source-Drain Diode Forward Voltage



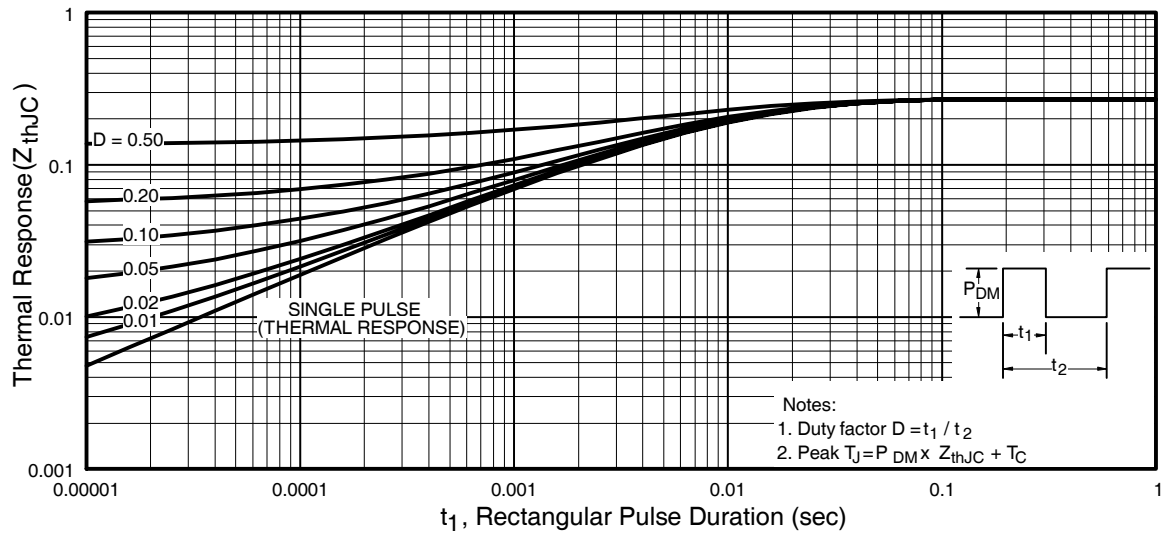
**Fig 9.** Maximum Drain Current vs. Case Temperature



**Fig 10a.** Switching Time Test Circuit



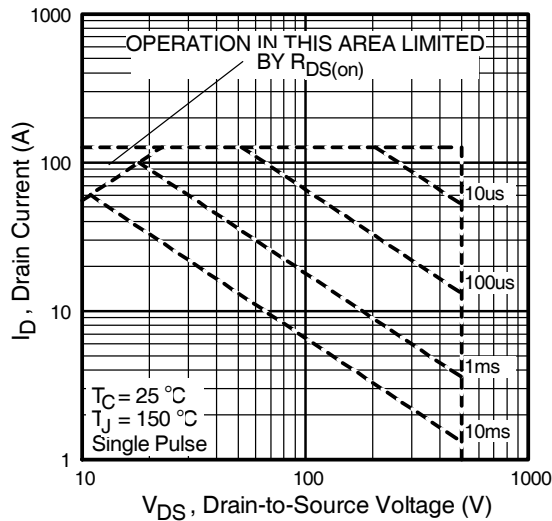
**Fig 10b.** Switching Time Waveforms



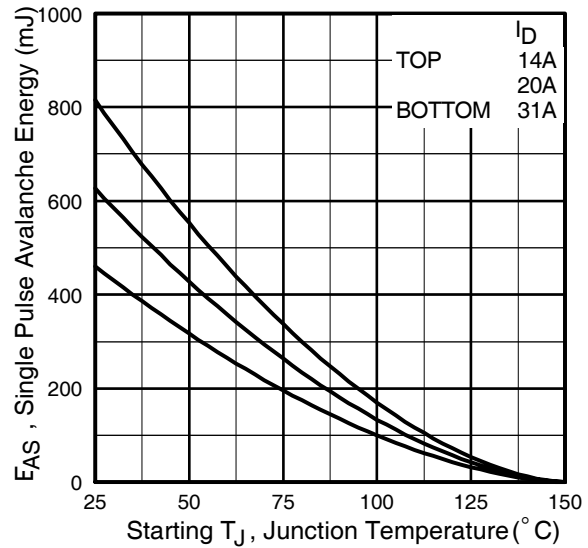
**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case

# IRFP31N50LPbF

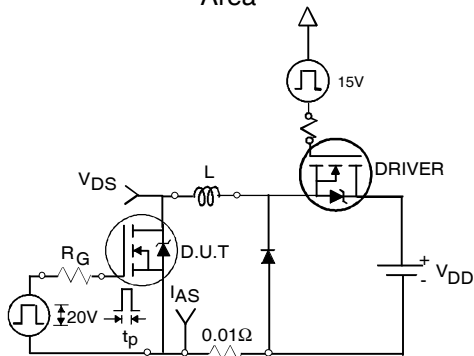
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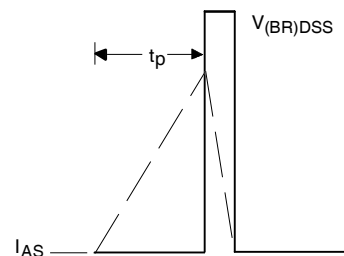
**Fig 12.** Maximum Safe Operating Area



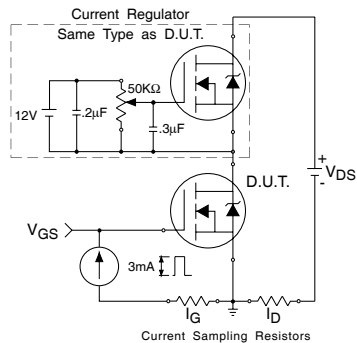
**Fig 13.** Maximum Avalanche Energy Vs. Drain Current



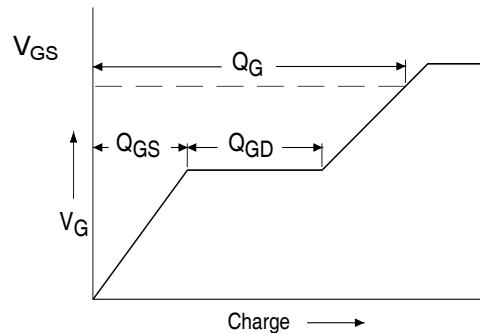
**Fig 14a.** Unclamped Inductive Test Circuit



**Fig 14b.** Unclamped Inductive Waveforms

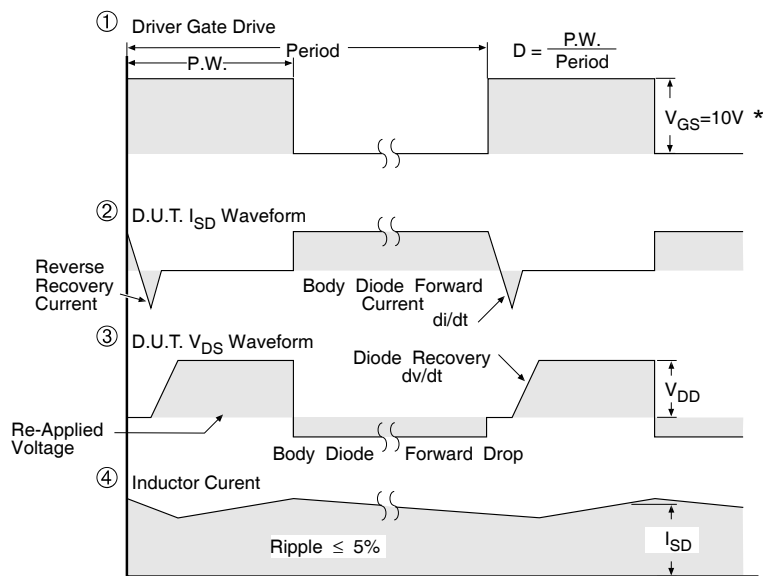
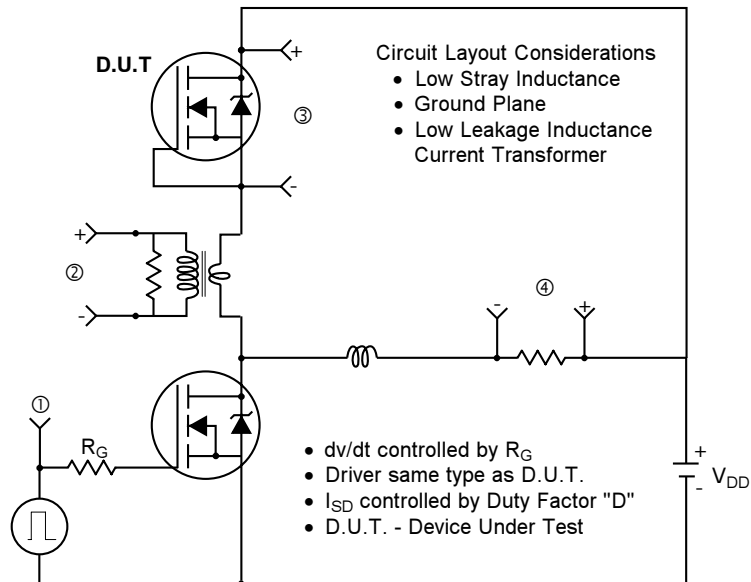


**Fig 15a.** Gate Charge Test Circuit



**Fig 15b.** Basic Gate Charge Waveform

## Peak Diode Recovery dv/dt Test Circuit



\*  $V_{GS} = 5V$  for Logic Level Devices

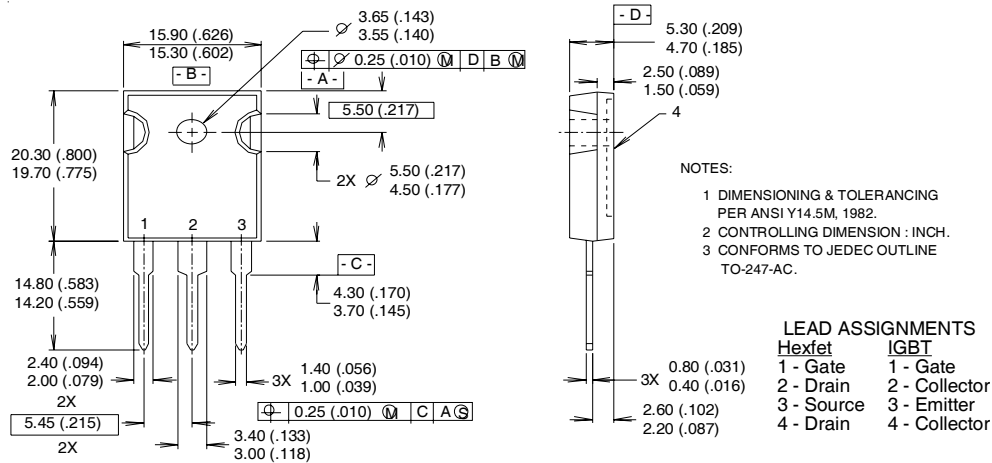
**Fig 16.** For N-Channel HEXFET® Power MOSFETs

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## TO-247AC Package Outline

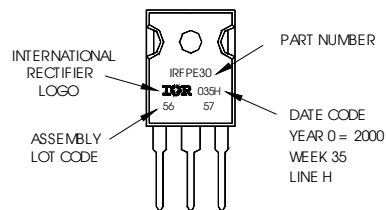
Dimensions are shown in millimeters (inches)



## TO-247AC Part Marking Information

EXAMPLE: THIS IS AN IRFPE30  
WITH ASSEMBLY  
LOT CODE 5657  
ASSEMBLED ON WW 35, 2000  
IN THE ASSEMBLY LINE "H"

**Note:** "P" in assembly line  
position indicates "Lead-Free"



**TO-247AC package is not recommended for Surface Mount Application.**

Data and specifications subject to change without notice.  
This product has been designed and qualified for the industrial market.  
Qualification Standards can be found on IR's Web site.

International  
**IR** Rectifier

**IR WORLD HEADQUARTERS:** 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105  
TAC Fax: (310) 252-7903  
02/04



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